

Search Notes

Application/Control No.

10/601,860

Examiner

Edgardo San Martin

Applicant(s)/Patent under
Reexamination

HAN, SUK-GYUN

Art Unit

2837

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
All of the previous searches were updated	7/14/2005	ESM
Text search EAST	7/14/2005	ESM